

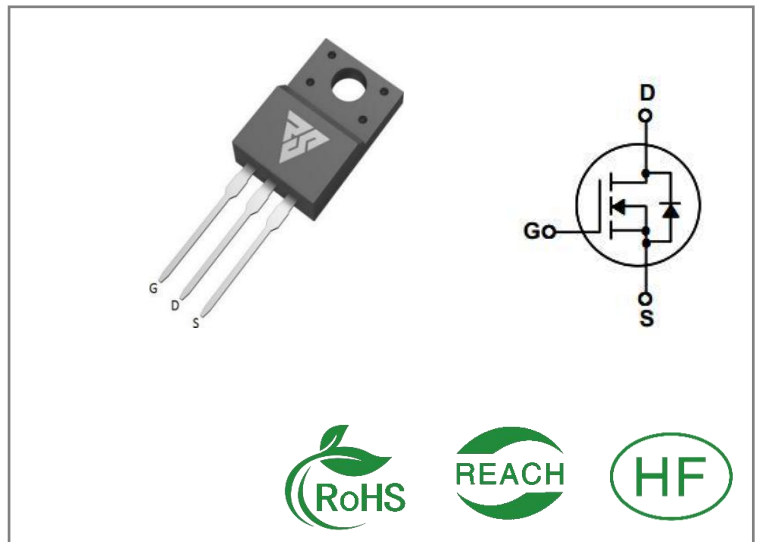
ID	R _{DS(ON)} (Typ)	VDSS
15A	200mΩ	650V

Applications:

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)
- AC-DC Switching Power Supply

Features:

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability



Ordering Information

Part Number	Package	Marking	Packing	Qty.
RS65T240F	T0-220F	RS65T240F	Tube	50 PCS

Absolute Maximum Ratings Tc= 25°C unless otherwise specified

Symbol	Parameter	RS65T240F	Units
VDSS	Drain-to-Source Voltage	650	V
ID	Continuous Drain Current TC=25°C	15	A
ID	Continuous Drain Current TC=100°C	9.1	
IDM	Pulsed Drain Current (Note*1)	45	
PD	Power Dissipation	34.7	W
	Derate above 25°C	0.278	W/°C
VGS	Gate- to- Source Voltage	±30	V
EAS	Single Pulse Avalanche Engergy L=10mH,VDD=100V, VG=10V , RG = 25 Ω , TC=25°C	324	mJ
dv/dt	Peak Diode Recovery dv/dt	15	V/ns
TL TPKG	Maximum Temperature for Soldering	300	°C
	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	260	
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the“ Absolute Maximum Ratings” Table may cause permanent damage to the device.

Thermal Resistance

Symbol	Parameter	RS65T240F	Units	Test Conditions
R θ JC	Junction-to-Case	3.6	°C / W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 °C
R θ JA	Junction-to-Ambient	63		1 cubic foot chamber, free air.

OFF Characteristics TJ= 25°C unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	650	--	--	V	VGS=0V ID=250μA
IDSS	Drain- to- Source Leakage Current	--	--	1	μA	VDS=650V VGS=0V
IGSS	Gate- to- Source Forward Leakage	--	--	100	nA	VGS=30V VDS=0V
	Gate- to- Source Reverse Leakage	--	--	-100		VGS=-30V VDS=0V

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On-Resistance	--	200	240	mΩ	VGS=10V ID=7A
VGS (TH)	Gate Threshold Voltage	2.5	3.5	4.5	V	VGS=V ID=250μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time	--	12	--	nS	VDS=325V ID=7.5A RG=25Ω
trise	Rise Time	--	22	--		
td(OFF)	Turn- OFF Delay Time	--	47	--		
tfall	Fall Time	--	70	--		

Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
Ciss	Input Capacitance	--	960	--	pF	VGS=0V VDS=100V f=1.0MHz
Coss	Output Capacitance	--	40	--		
Crss	Reverse Transfer Capacitance	--	1.8	--		
Qg	Total Gate Charge	--	19	--	nC	VDS=325V ID=7.5A VGS=10V
Qgs	Gate- to- Source Charge	--	6	--		
Qgd	Gate-to-Drain(" Miller") Charge	--	5.5	--		

Source- Drain Diode Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Units	Test Conditions
IS	Continuous Source Current	--	--	15	A	Integral pn- diode in MOSFET
ISM	Maximum Pulsed Current	--	--	45	A	
VSD	Diode Forward Voltage	--	--	1.4	V	IS=15A VGS=0V
trr	Reverse Recovery Time	--	196	--	nS	VGS=0V IS=7.5A di/dt=100A/μs
Qrr	Reverse Recovery Charge	--	1.9	--	μC	

Notes:

* 1. Repetitive rating, pulse width limited by maximum junction temperature.

Typical Feature Curve

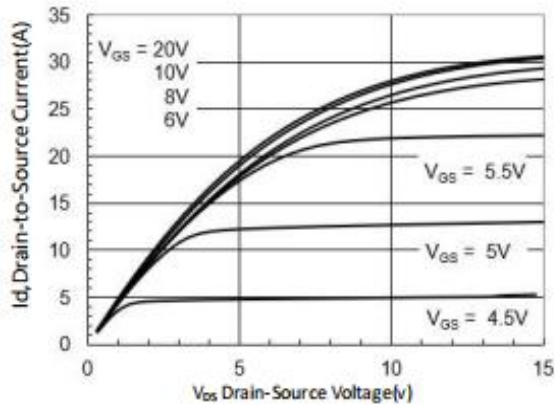


Figure1. Typical Output Characteristics

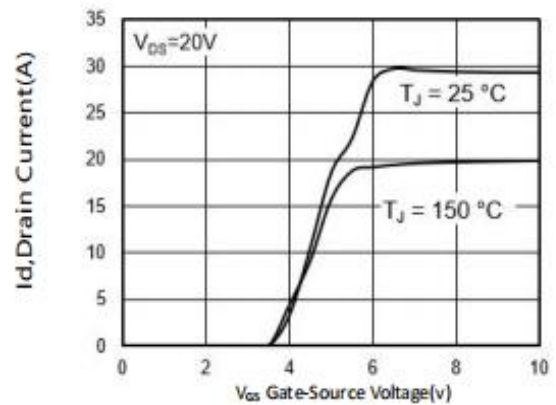


Figure2. Typical Transfer Characteristics

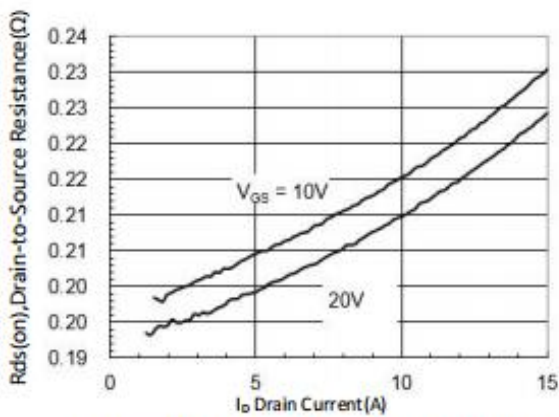


Figure3. On-Resistance versus Drain Current

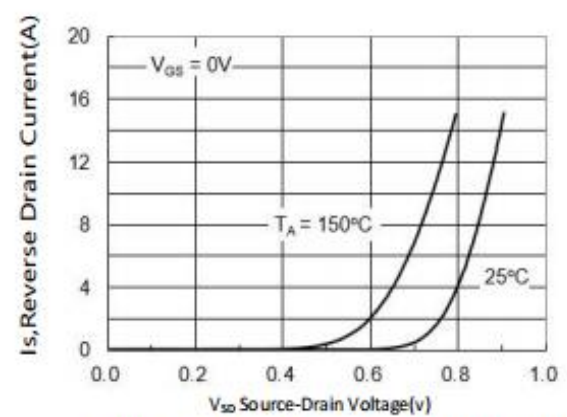


Figure4. Diode forward voltage versus Current

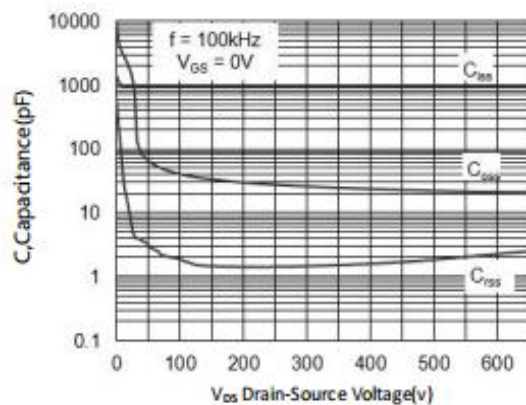


Figure5. Typical Capacitance versus V_{DS}

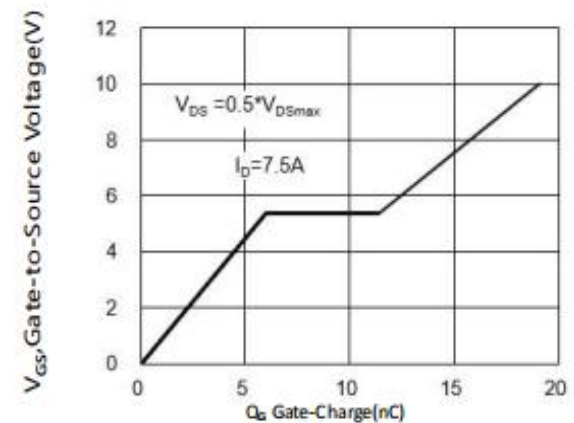


Figure6. Typical Gate Charge versus V_{GS}

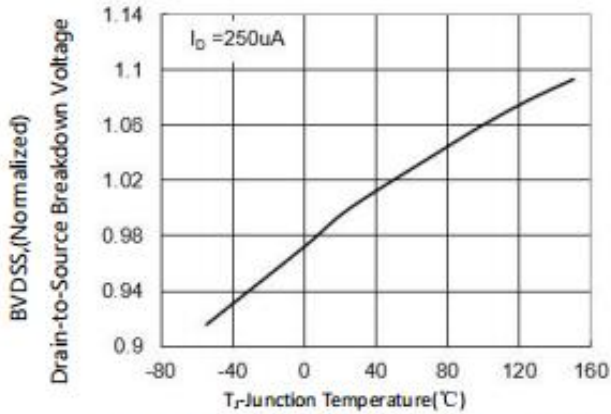


Figure 7. BV_{DSS} Variation with Temperature

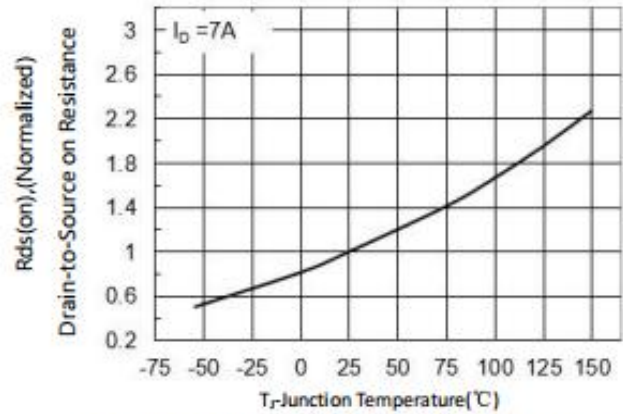
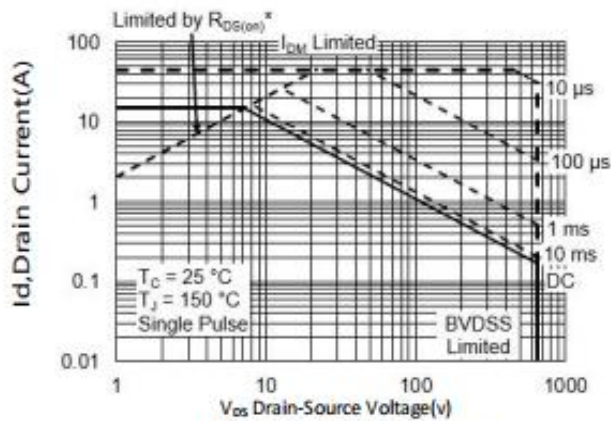
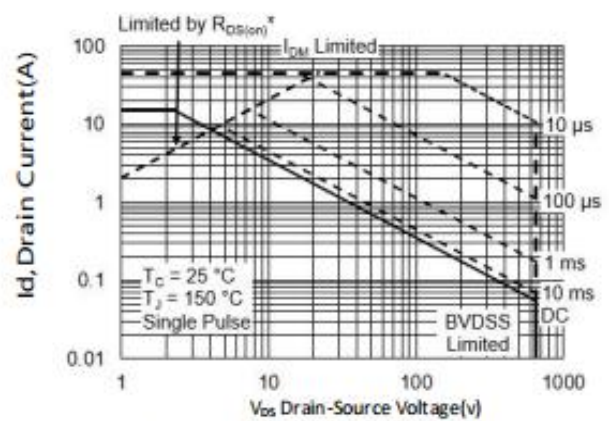


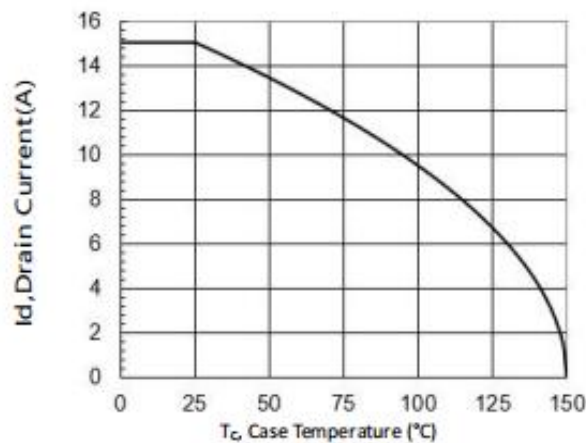
Figure 8. On-Resistance Variation with Temperature



**Figure 9. Maximum Safe Operating Area
TO-220/TO-252**

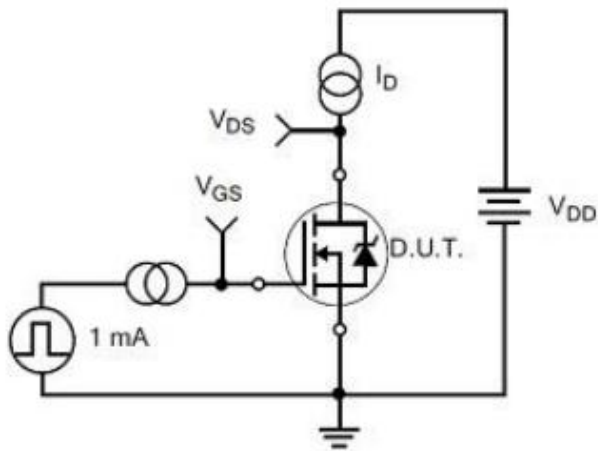


**Figure 9. Maximum Safe Operating Area
TO-220F**

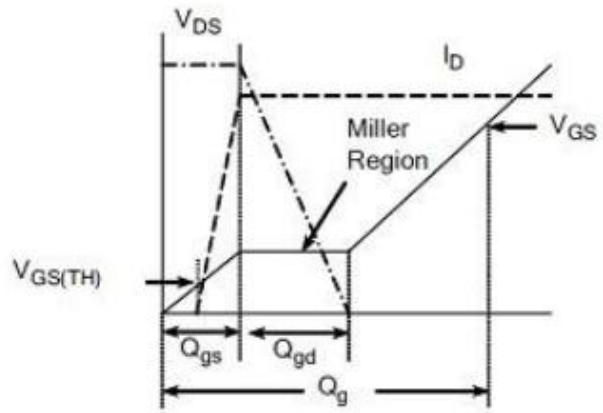


**Figure 10. Maximum Continuous Drain Current
versus Case Temperature**

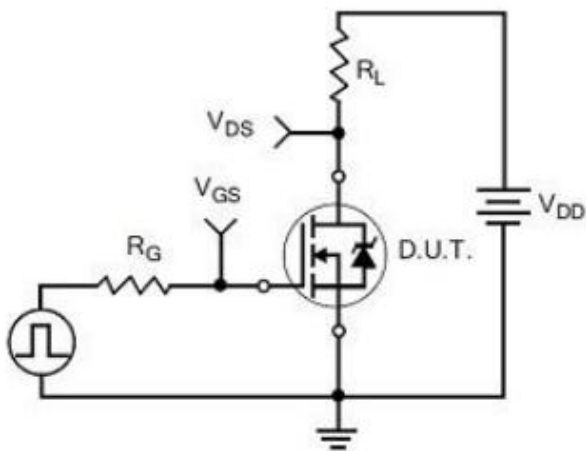
Test Circuits and Waveforms



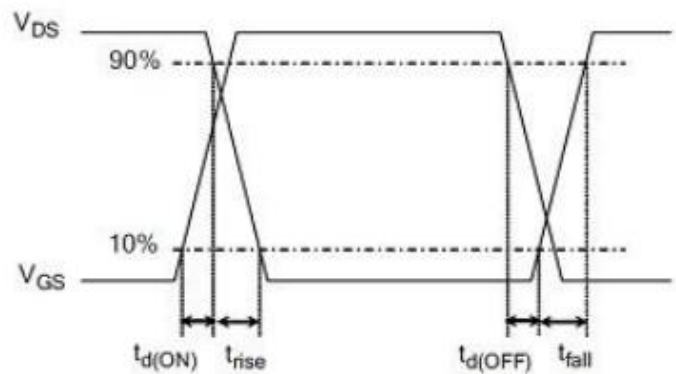
Gate Charge Test Circuit



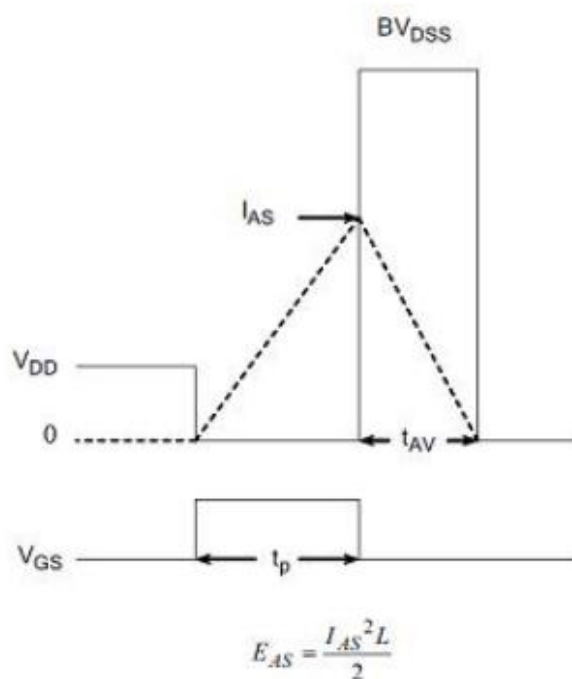
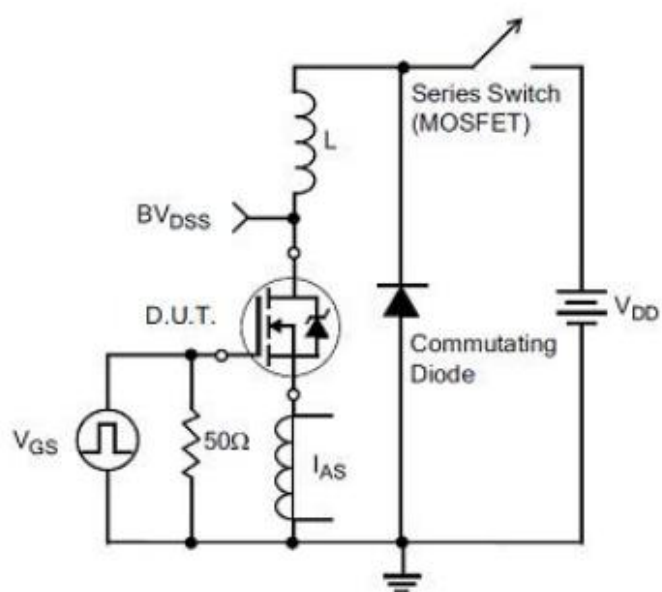
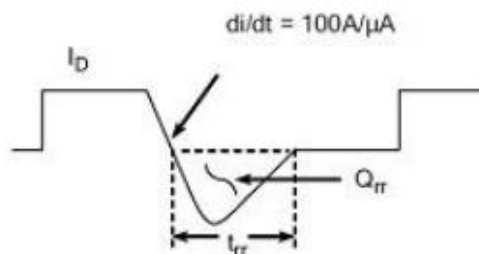
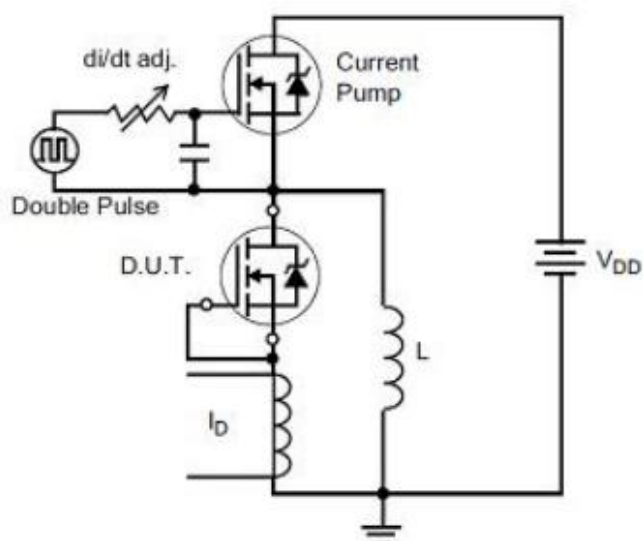
Gate Charge Waveform



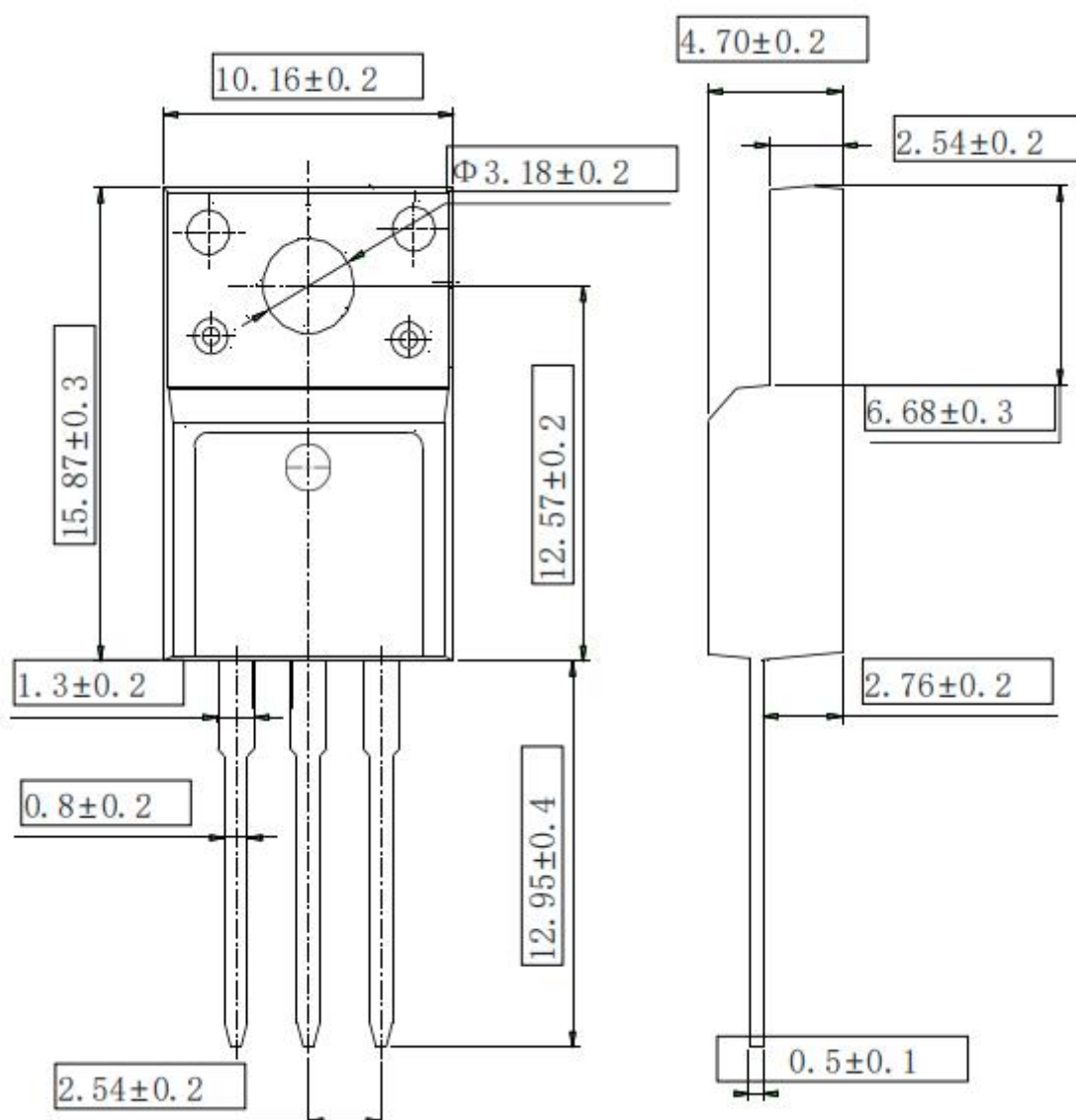
Resistive Switching Test Circuit



Resistive Switching Waveforms



Package outline drawing (TO-220F Unit: mm)



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